

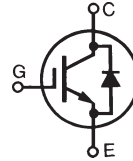
**XPT™ 650V IGBT  
GenX3™ w/ Diode**
**IXYH40N65C3D1  
IXYQ40N65C3D1**

$$V_{CES} = 650V$$

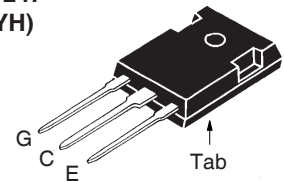
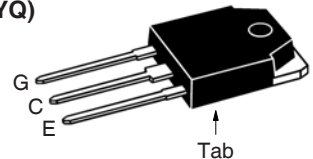
$$I_{C110} = 40A$$

$$V_{CE(sat)} \leq 2.35V$$

$$t_{fi(typ)} = 20ns$$

 Extreme Light Punch Through  
IGBT for 20-60 kHz Switching


| Symbol                        | Test Conditions   | Maximum Ratings                         |            |
|-------------------------------|---|---|------------|
|                               |   |   |            |
| $V_{CES}$                     | $T_J = 25^\circ C$ to $175^\circ C$   | 650                                     | V          |
| $V_{CGR}$                     | $T_J = 25^\circ C$ to $175^\circ C$ , $R_{GE} = 1M\Omega$                                   | 650                                     | V          |
| $V_{GES}$                     | Continuous  | $\pm 20$                                | V          |
| $V_{GEM}$                     | Transient   | $\pm 30$                                | V          |
| $I_{C25}$                     | $T_C = 25^\circ C$  | 80                                      | A          |
| $I_{C110}$                    | $T_C = 110^\circ C$   | 40                                      | A          |
| $I_{F110}$                    | $T_C = 110^\circ C$   | 50                                      | A          |
| $I_{CM}$                      | $T_C = 25^\circ C$ , 1ms  | 180                                     | A          |
| $I_A$                         | $T_C = 25^\circ C$  | 20                                      | A          |
| $E_{AS}$                      | $T_C = 25^\circ C$  | 300                                     | mJ         |
| <b>SSOA</b><br><b>(RBSOA)</b> | $V_{GE} = 15V$ , $T_{VJ} = 150^\circ C$ , $R_G = 10\Omega$<br>Clamped Inductive Load        | $I_{CM} = 80$<br>$@V_{CE} \leq V_{CES}$ | A          |
| $t_{sc}$<br><b>(SCSOA)</b>    | $V_{GE} = 15V$ , $V_{CE} = 360V$ , $T_J = 150^\circ C$<br>$R_G = 82\Omega$ , Non Repetitive | 5                                       | $\mu s$    |
| $P_C$                         | $T_C = 25^\circ C$  | 300                                     | W          |
| $T_J$                         |   | -55 ... +175                            | $^\circ C$ |
| $T_{JM}$                      |   | 175                                     | $^\circ C$ |
| $T_{stg}$                     |   | -55 ... +175                            | $^\circ C$ |
| $T_L$                         | Maximum Lead Temperature for Soldering  | 300                                     | $^\circ C$ |
| $T_{SOLD}$                    | 1.6 mm (0.062in.) from Case for 10s   | 260                                     | $^\circ C$ |
| $M_d$                         | Mounting Torque   | 1.13/10                                 | Nm/lb.in   |
| <b>Weight</b>                 | TO-247  | 6.0                                     | g          |
|                               | TO-3P   | 5.5                                     | g          |

**TO-247  
(IXYH)**

**TO-3P  
(IXYQ)**


G = Gate                      C = Collector  
E = Emitter                  Tab = Collector

**Features**

- Optimized for 20-60kHz Switching
- Square RBSOA
- Anti-Parallel Fast Diode
- Avalanche Rated
- Short Circuit Capability

**Advantages**

- High Power Density
- Extremely Rugged
- Low Gate Drive Requirement

**Applications**

- Power Inverters
- UPS
- Motor Drives
- SMPS
- PFC Circuits
- Battery Chargers
- Welding Machines
- Lamp Ballasts
- High Frequency Power Inverters

| Symbol        | Test Conditions<br>( $T_J = 25^\circ C$ , Unless Otherwise Specified) | Characteristic Values |            |                      |
|---------------|---|-----------------------|------------|----------------------|
|               |   | Min.                  | Typ.       | Max.                 |
| $BV_{CES}$    | $I_C = 250\mu A$ , $V_{GE} = 0V$                                      | 650                   |            | V                    |
| $V_{GE(th)}$  | $I_C = 250\mu A$ , $V_{CE} = V_{GE}$                                  | 3.5                   |            | 6.0 V                |
| $I_{CES}$     | $V_{CE} = V_{CES}$ , $V_{GE} = 0V$<br>$T_J = 150^\circ C$             |                       |            | 10 $\mu A$<br>1.5 mA |
| $I_{GES}$     | $V_{CE} = 0V$ , $V_{GE} = \pm 20V$                                    |                       |            | $\pm 100$ nA         |
| $V_{CE(sat)}$ | $I_C = 40A$ , $V_{GE} = 15V$ , Note 1<br>$T_J = 150^\circ C$          |                       | 2.0<br>2.4 | 2.35 V<br>V          |

| Symbol Test Conditions<br>( $T_J = 25^\circ\text{C}$ Unless Otherwise Specified) |  | Characteristic Values |      |                         |
|--|--|-----------------------|------|-------------------------|
|  |  | Min.                  | Typ. | Max.                    |
| $g_{fs}$   | $I_C = 40\text{A}, V_{CE} = 10\text{V}, \text{Note 1}$   | 16                    | 26   | S                       |
| $C_{ies}$  | $V_{CE} = 25\text{V}, V_{GE} = 0\text{V}, f = 1\text{MHz}$   |                       | 1950 | pF                      |
| $C_{oes}$  |  | 205                   | pF   |                         |
| $C_{res}$  |  | 40                    | pF   |                         |
| $Q_{g(on)}$  | $I_C = 40\text{A}, V_{GE} = 15\text{V}, V_{CE} = 0.5 \cdot V_{CES}$  |                       | 66   | nC                      |
| $Q_{ge}$   |  | 13                    | nC   |                         |
| $Q_{gc}$   |  | 32                    | nC   |                         |
| $t_{d(on)}$  | <b>Inductive load, <math>T_J = 25^\circ\text{C}</math></b><br>$I_C = 30\text{A}, V_{GE} = 15\text{V}$<br>$V_{CE} = 400\text{V}, R_G = 10\Omega$<br>Note 2  |                       | 23   | ns                      |
| $t_{ri}$   |  | 40                    | ns   |                         |
| $E_{on}$   |  | 0.83                  | mJ   |                         |
| $t_{d(off)}$   |  | 110                   | ns   |                         |
| $t_{fi}$   |  | 20                    | ns   |                         |
| $E_{off}$  | 0.36   | 0.65                  | mJ   |                         |
| $t_{d(on)}$  | <b>Inductive load, <math>T_J = 150^\circ\text{C}</math></b><br>$I_C = 30\text{A}, V_{GE} = 15\text{V}$<br>$V_{CE} = 400\text{V}, R_G = 10\Omega$<br>Note 2 |                       | 24   | ns                      |
| $t_{ri}$   |  | 40                    | ns   |                         |
| $E_{on}$   |  | 1.60                  | mJ   |                         |
| $t_{d(off)}$   |  | 130                   | ns   |                         |
| $t_{fi}$   |  | 30                    | ns   |                         |
| $E_{off}$  | 0.53   | mJ                    |      |                         |
| $R_{thJC}$   |  |                       |      | 0.50 $^\circ\text{C/W}$ |
| $R_{thCS}$   |  | 0.25                  |      | $^\circ\text{C/W}$      |

**Reverse Fast Recovery Diode (FRED)**

| Symbol Test Conditions<br>( $T_J = 25^\circ\text{C}$ Unless Otherwise Specified) |  | Characteristic Values     |      |                         |
|--|--|---------------------------|------|-------------------------|
|  |  | Min.                      | Typ. | Max.                    |
| $V_F$  | $I_F = 30\text{A}, V_{GE} = 0\text{V}, \text{Note 1}$  |                           |      | 2.5 V                   |
| $I_{rr}$   | $I_F = 30\text{A}, V_{GE} = 0\text{V},$<br>$-di_F/dt = 500\text{A}/\mu\text{s}, V_R = 400\text{V}$ | $T_J = 150^\circ\text{C}$ | 1.2  | V                       |
| $t_{rr}$   |  | $T_J = 150^\circ\text{C}$ | 23   | A                       |
| $R_{thJC}$   |  |                           |      | 0.60 $^\circ\text{C/W}$ |

**Notes:**

1. Pulse test,  $t \leq 300\mu\text{s}$ , duty cycle,  $d \leq 2\%$ .
2. Switching times & energy losses may increase for higher  $V_{CE}(\text{clamp})$ ,  $T_J$  or  $R_G$ .

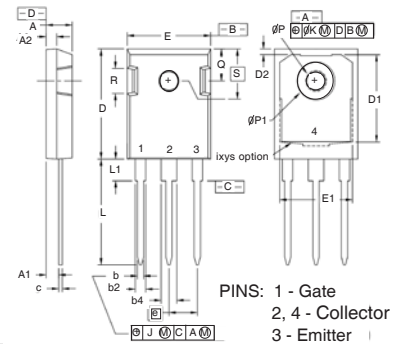
**PRELIMINARY TECHNICAL INFORMATION**

The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

**IXYS Reserves the Right to Change Limits, Test Conditions, and Dimensions.**

|  |           |           |           |           |              |              |              |              |              |             |
|--|-----------|-----------|-----------|-----------|--------------|--------------|--------------|--------------|--------------|-------------|
| IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: | 4,835,592 | 4,931,844 | 5,049,961 | 5,237,481 | 6,162,665    | 6,404,065 B1 | 6,683,344    | 6,727,585    | 7,005,734 B2 | 7,157,338B2 |
|  | 4,860,072 | 5,017,508 | 5,063,307 | 5,381,025 | 6,259,123 B1 | 6,534,343    | 6,710,405 B2 | 6,759,692    | 7,063,975 B2 |             |
|  | 4,881,106 | 5,034,796 | 5,187,117 | 5,486,715 | 6,306,728 B1 | 6,583,505    | 6,710,463    | 6,771,478 B2 | 7,071,537    |             |

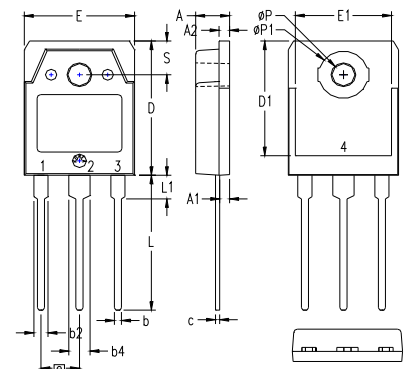
**TO-247 Outline**



PINS: 1 - Gate  
2, 4 - Collector  
3 - Emitter

| SYM       | INCHES   |      | MILLIMETERS |       |
|-----------|----------|------|-------------|-------|
|           | MIN      | MAX  | MIN         | MAX   |
| A         | .190     | .205 | 4.83        | 5.21  |
| A1        | .090     | .100 | 2.29        | 2.54  |
| A2        | .075     | .085 | 1.91        | 2.16  |
| b         | .045     | .055 | 1.14        | 1.40  |
| b2        | .075     | .087 | 1.91        | 2.20  |
| b4        | .115     | .126 | 2.92        | 3.20  |
| C         | .024     | .031 | 0.61        | 0.80  |
| D         | .819     | .840 | 20.80       | 21.34 |
| D1        | .650     | .690 | 16.51       | 17.53 |
| D2        | .035     | .050 | 0.89        | 1.27  |
| E         | .620     | .635 | 15.75       | 16.13 |
| E1        | .545     | .565 | 13.84       | 14.35 |
| e         | .215 BSC |      | 5.45 BSC    |       |
| J         | --       | .010 | --          | 0.25  |
| K         | --       | .025 | --          | 0.64  |
| L         | .780     | .810 | 19.81       | 20.57 |
| L1        | .150     | .170 | 3.81        | 4.32  |
| $\phi P$  | .140     | .144 | 3.55        | 3.65  |
| $\phi P1$ | .275     | .290 | 6.99        | 7.37  |
| Q         | .220     | .244 | 5.59        | 6.20  |
| R         | .170     | .190 | 4.32        | 4.83  |
| S         | .242 BSC |      | 6.15 BSC    |       |

**TO-3P Outline**



Pins: 1 - Gate 2 - Collector  
3 - Emitter 4 - Collector

| SYM       | INCHES   |      | MILLIMETERS |       |
|-----------|----------|------|-------------|-------|
|           | MIN      | MAX  | MIN         | MAX   |
| A         | .185     | .193 | 4.70        | 4.90  |
| A1        | .051     | .059 | 1.30        | 1.50  |
| A2        | .057     | .065 | 1.45        | 1.65  |
| b         | .035     | .045 | 0.90        | 1.15  |
| b2        | .075     | .087 | 1.90        | 2.20  |
| b4        | .114     | .126 | 2.90        | 3.20  |
| c         | .022     | .031 | 0.55        | 0.80  |
| D         | .780     | .791 | 19.80       | 20.10 |
| D1        | .665     | .677 | 16.90       | 17.20 |
| E         | .610     | .622 | 15.50       | 15.80 |
| E1        | .531     | .539 | 13.50       | 13.70 |
| e         | .215 BSC |      | 5.45 BSC    |       |
| L         | .779     | .795 | 19.80       | 20.20 |
| L1        | .134     | .142 | 3.40        | 3.60  |
| $\phi P$  | .126     | .134 | 3.20        | 3.40  |
| $\phi P1$ | .272     | .280 | 6.90        | 7.10  |
| S         | .193     | .201 | 4.90        | 5.10  |

Fig. 1. Output Characteristics @  $T_J = 25^\circ\text{C}$

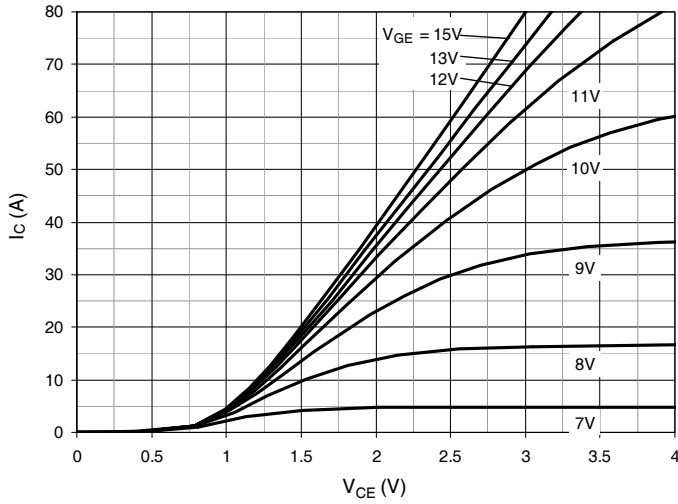


Fig. 2. Extended Output Characteristics @  $T_J = 25^\circ\text{C}$

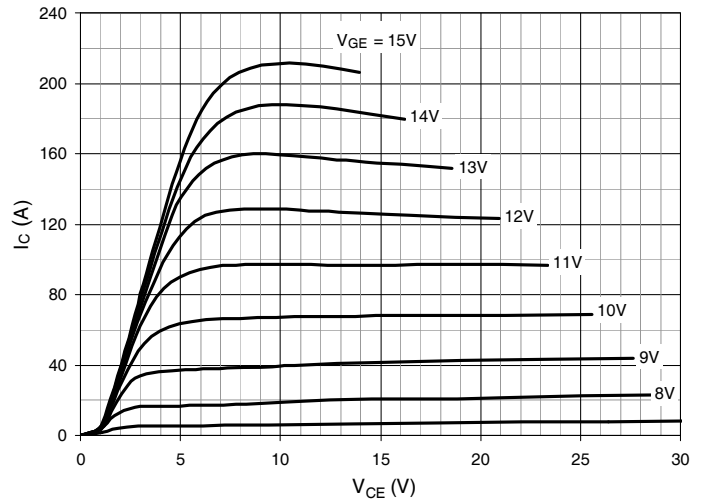


Fig. 3. Output Characteristics @  $T_J = 150^\circ\text{C}$

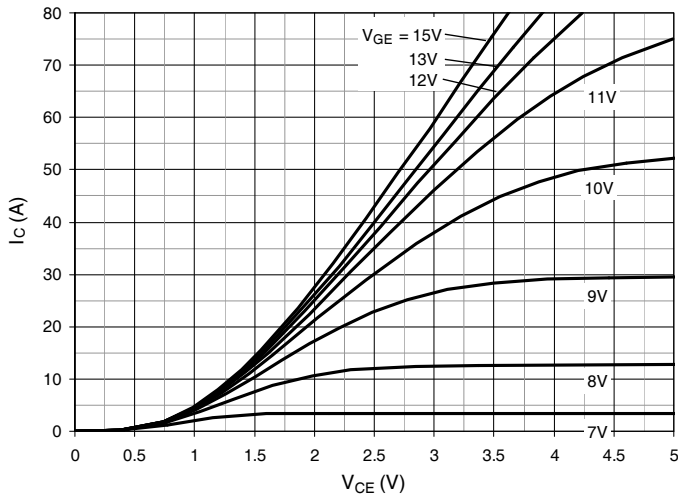


Fig. 4. Dependence of  $V_{CE(sat)}$  on Junction Temperature

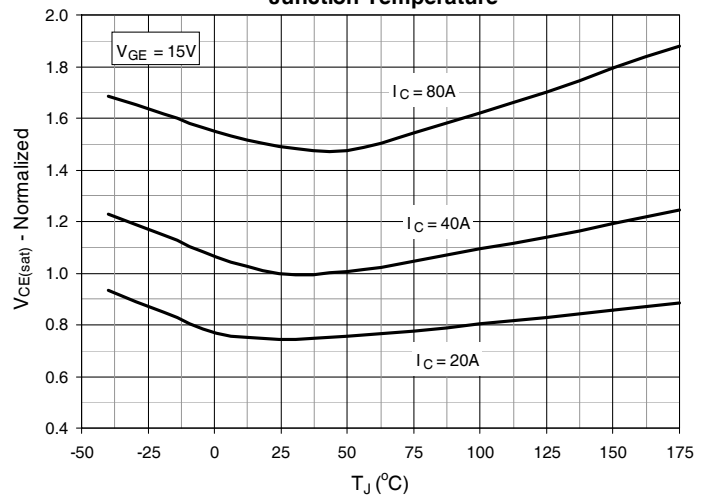


Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter Voltage

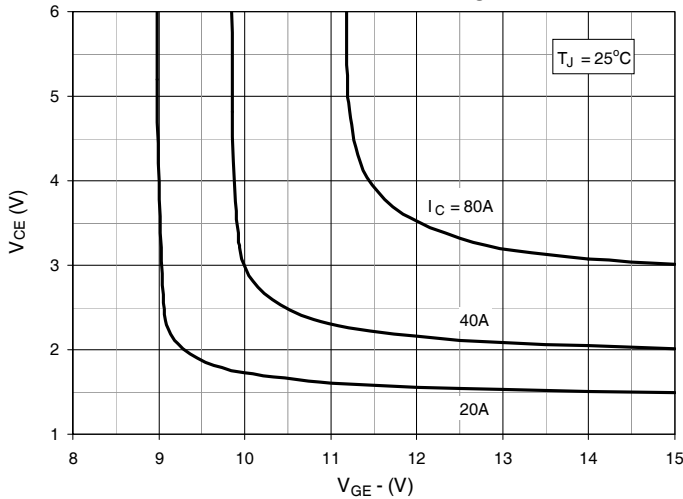


Fig. 6. Input Admittance

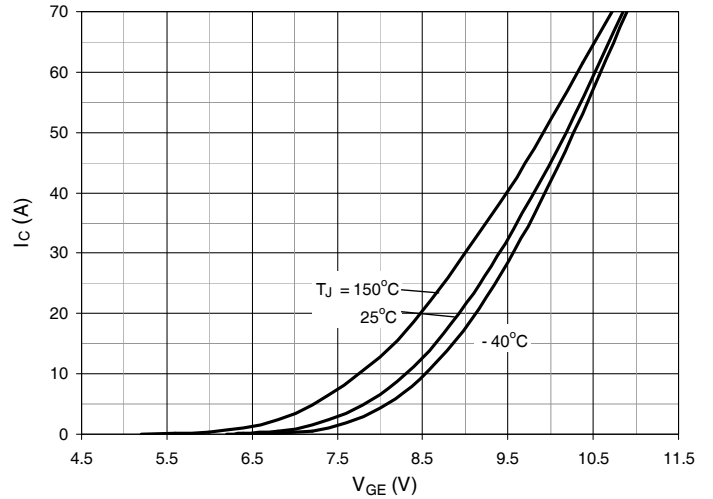


Fig. 7. Transconductance

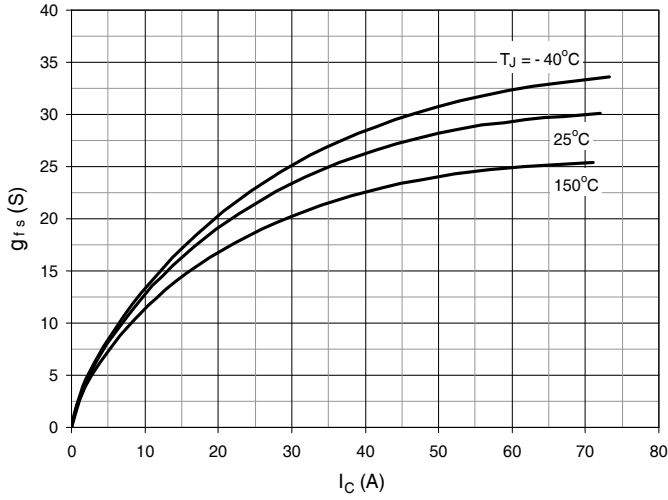


Fig. 8. Gate Charge

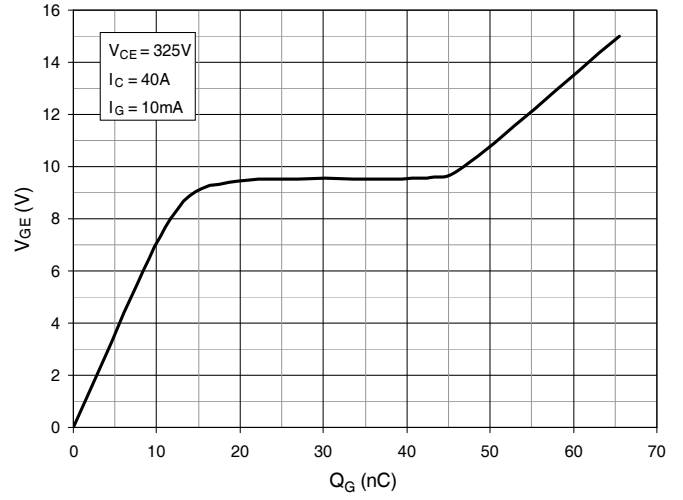


Fig. 9. Capacitance

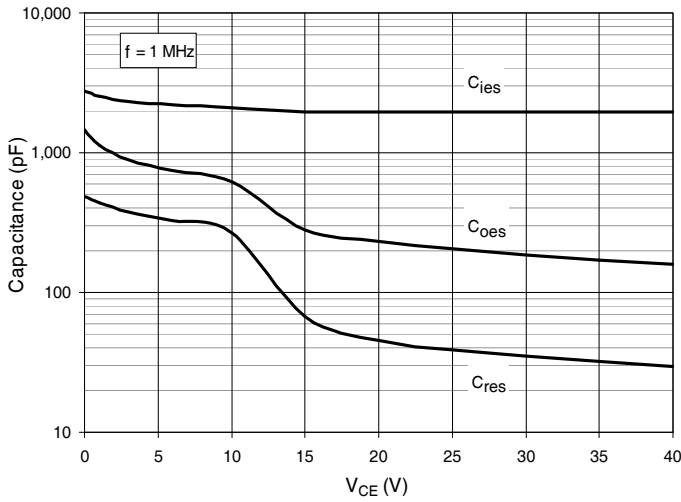


Fig. 10. Reverse-Bias Safe Operating Area

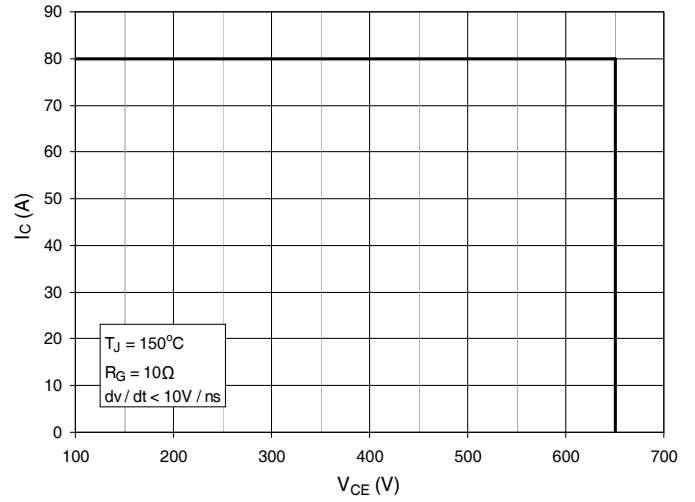


Fig. 11. Forward-Bias Safe Operating Area

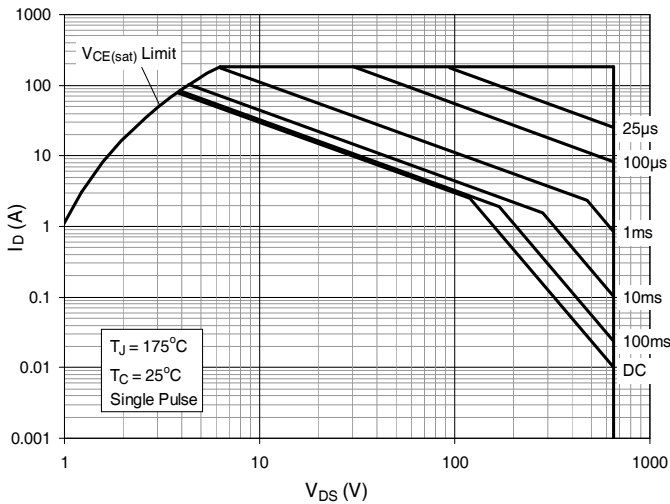
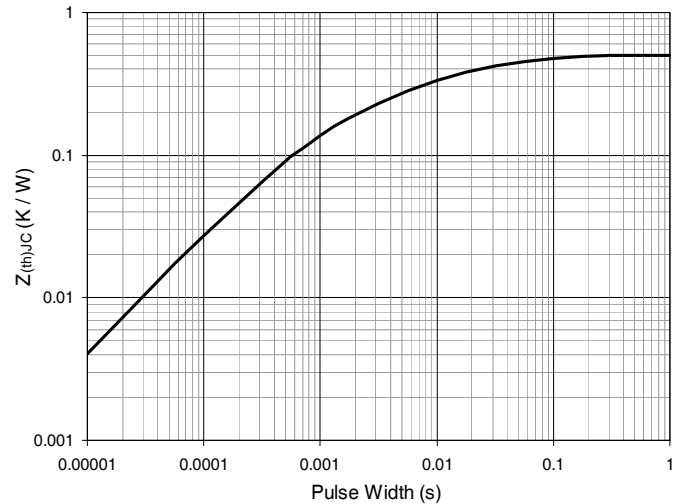
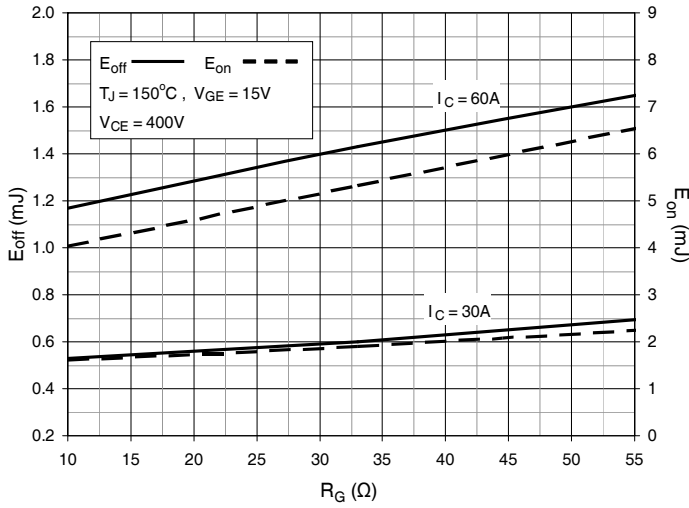


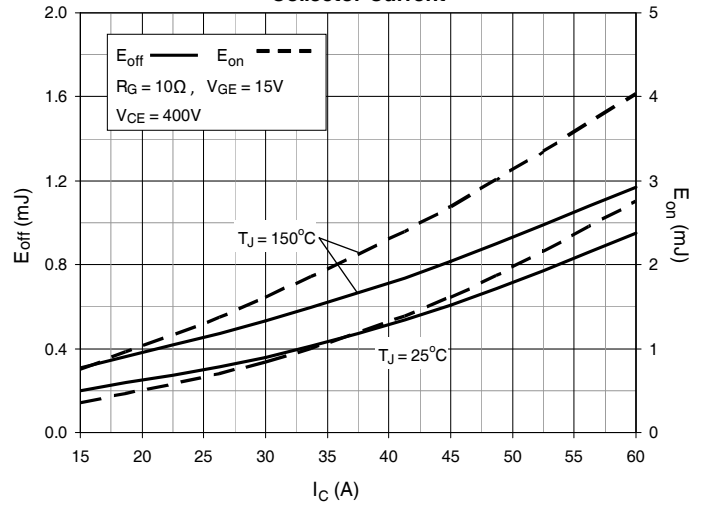
Fig. 12. Maximum Transient Thermal Impedance (IGBT)



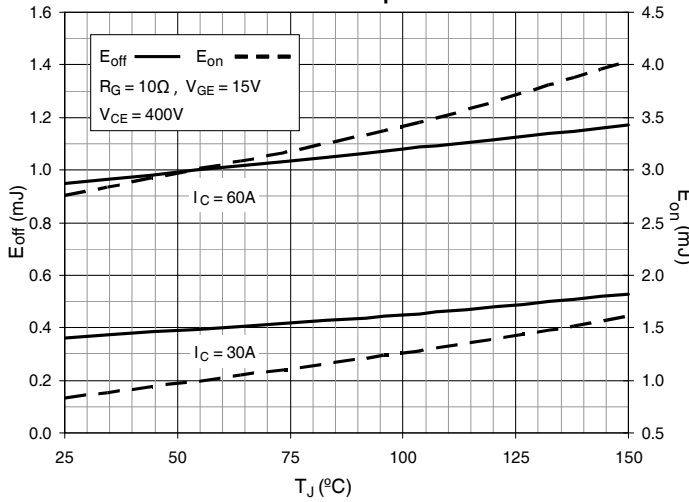
**Fig. 13. Inductive Switching Energy Loss vs. Gate Resistance**



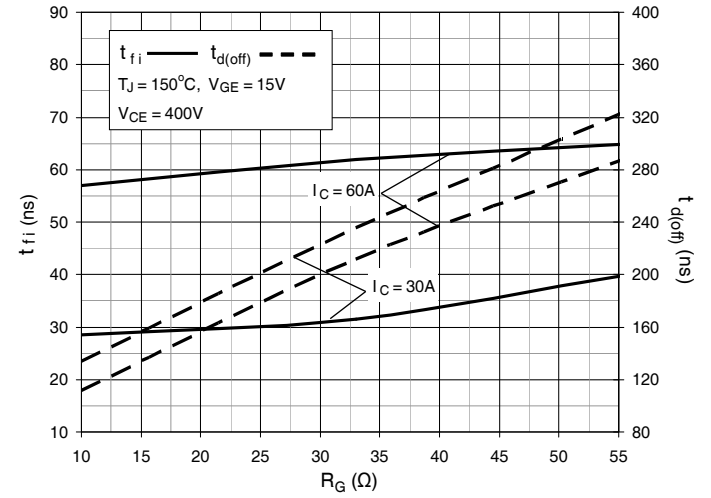
**Fig. 14. Inductive Switching Energy Loss vs. Collector Current**



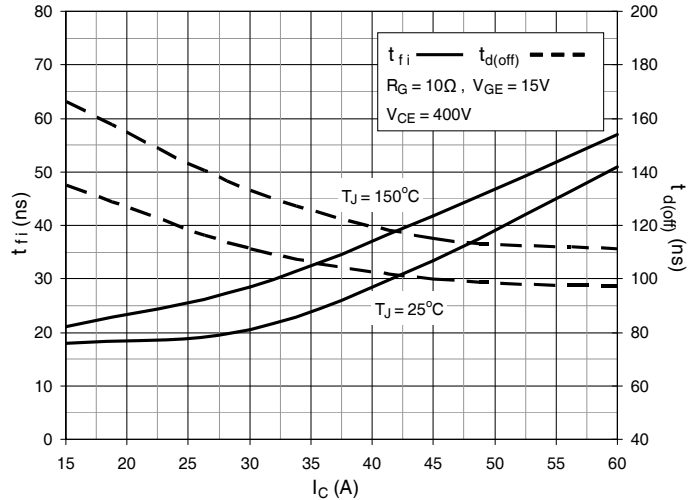
**Fig. 15. Inductive Switching Energy Loss vs. Junction Temperature**



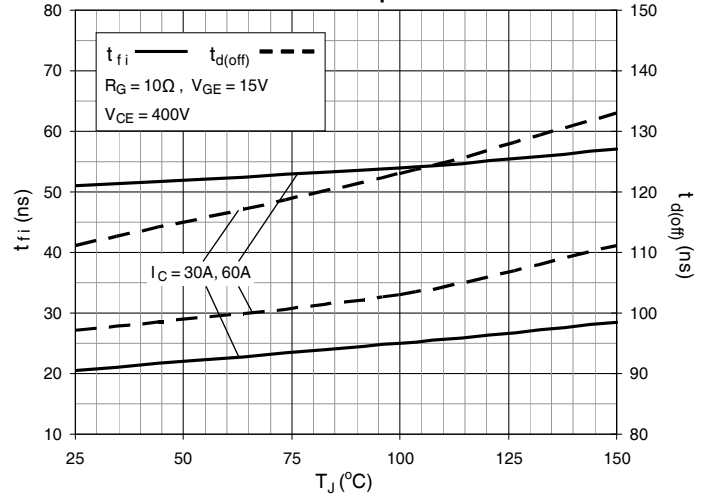
**Fig. 16. Inductive Turn-off Switching Times vs. Gate Resistance**



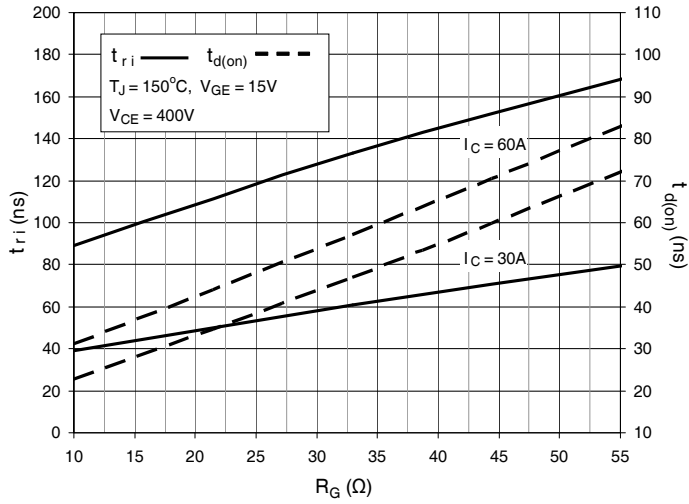
**Fig. 17. Inductive Turn-off Switching Times vs. Collector Current**



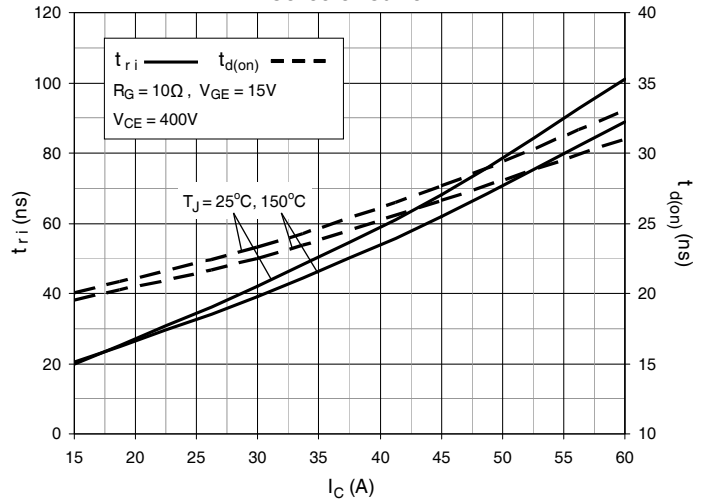
**Fig. 18. Inductive Turn-off Switching Times vs. Junction Temperature**



**Fig. 19. Inductive Turn-on Switching Times vs. Gate Resistance**



**Fig. 20. Inductive Turn-on Switching Times vs. Collector Current**



**Fig. 21. Inductive Turn-on Switching Times vs. Junction Temperature**

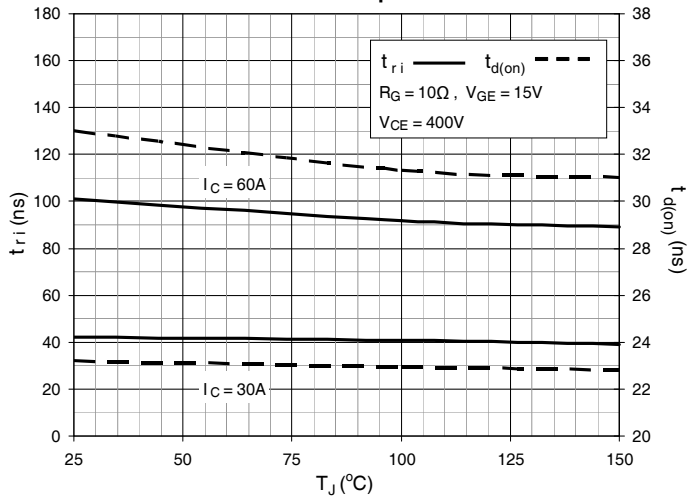


Fig. 22. Diode Forward Characteristics

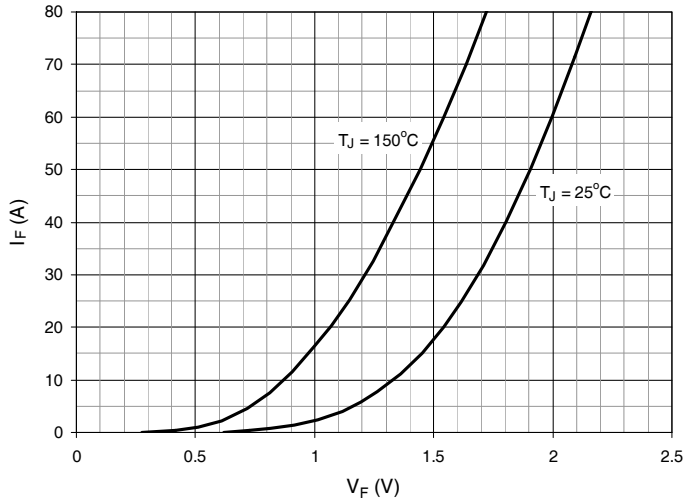


Fig. 23. Reverse Recovery Charge vs.  $-di_F/dt$

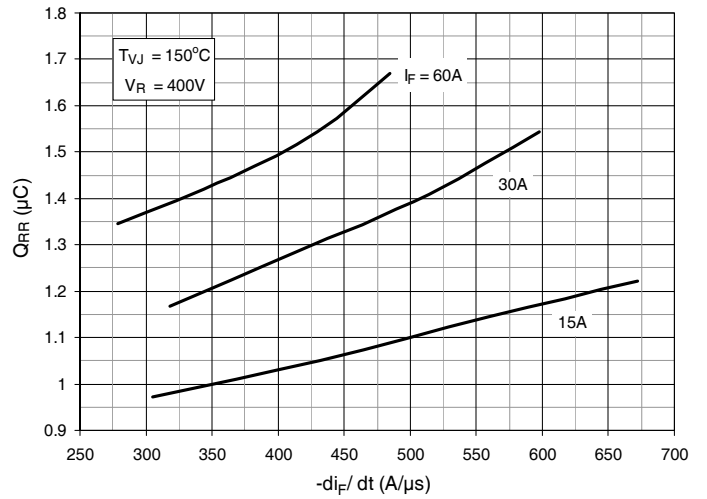


Fig. 24. Reverse Recovery Current vs.  $-di_F/dt$

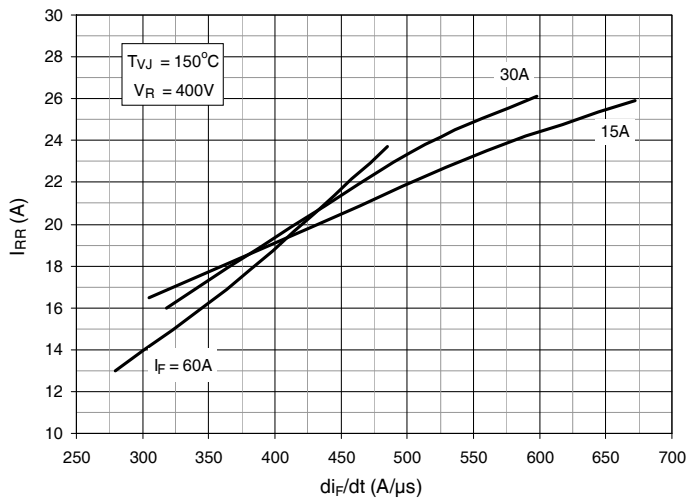


Fig. 25. Reverse Recovery Time vs.  $-di_F/dt$

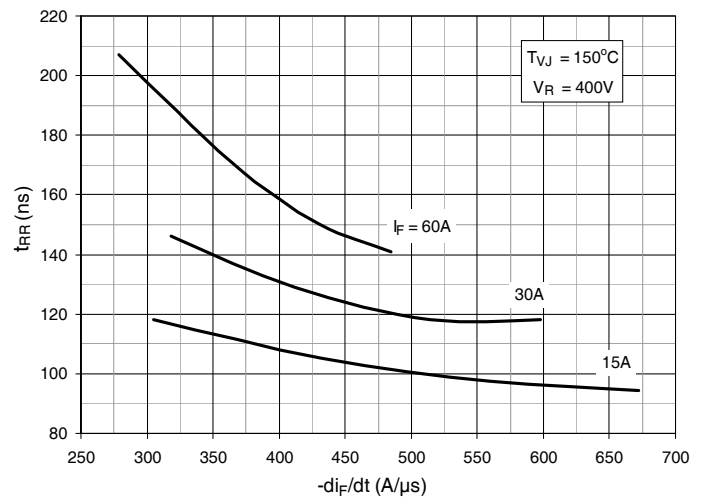


Fig. 26. Dynamic Parameters  $Q_{RR}$ ,  $I_{RR}$  vs. Junction Temperature

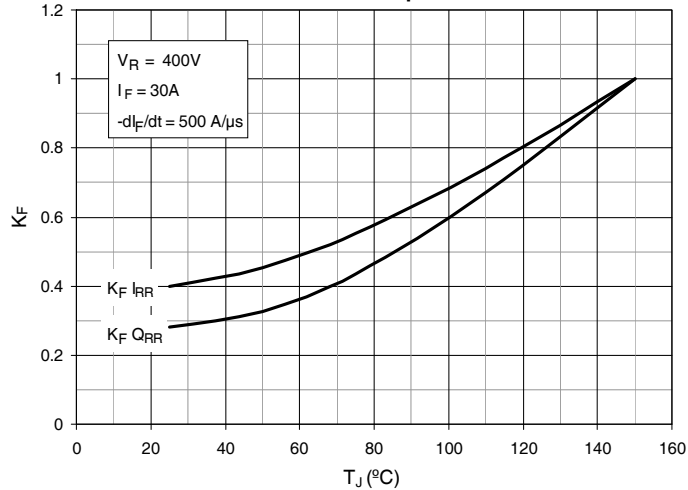
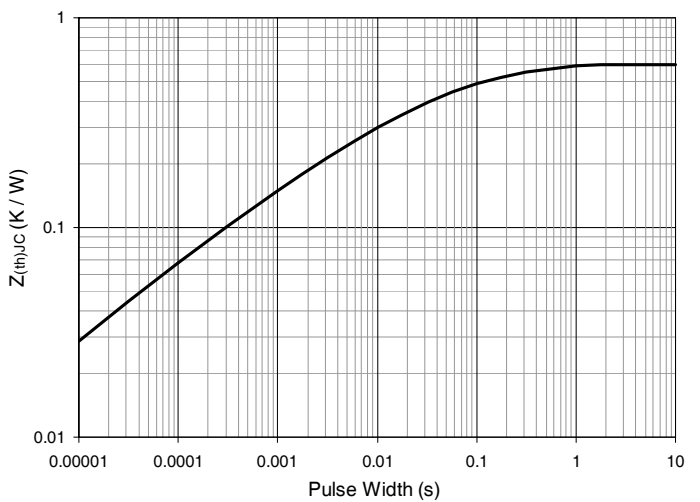


Fig. 27. Maximum Transient Thermal Impedance (Diode)





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